Amendments to Claims

Please amend the claims as follows:

1.(currently amended) A method of fabricating a microstructure for micro-fluidics applications, comprising the steps of:

forming a layer of etchable material on a substrate;

forming a mechanically stable support layer over said etchable material;

performing an anisotropic etch through a mask to form a pattern of holes extending through said support layer into said etchable material and Jving along a projected path of a continuous micro-channel to be formed within said etchable material, , said holes being separated from each other by a predetermined distance;

performing an isotropic etch through each said hole to form a corresponding cavity in said etchable material under each said hole, said corresponding cavity and extending under said support layer to communicate with an adjacent said cavity whereby a series of said communicating cavities form said micro-channel; and

forming a further layer of depositable material over said support layer until <u>overhanging</u> portions of said depositable layer <u>overhanging each said hole</u> meet <u>and to</u> thereby-close the eavity formed under each said hole.

- 2.(cancelled)
- 3.(currently amended) A method as claimed in claim 21, wherein the hole size lies in the range 0.3 μm to 5.0 μm.
- 4.(original) A method as claimed in claim 3, wherein the hole size is about 0.8 μm.
- 5.(currently amended) A method as claimed in claim 21, wherein the distance between neighboring holes lies in the range 0.8 µm to 10.0 µm.
- 6.(original) A method as claimed in claim 1, wherein the distance between neighboring holes is about 2.0 μm.
- 7.(cancelled) .
- 8.(currently amended) A method as claimed in claim 21, wherein said pattern is T-shaped and said isotropic etch results in a T-shaped micro-channel.

- 9.(currently amended) A method as claimed in claim 21, wherein said pattern is cross-shaped and said isotropic etch results in intersecting micro-channels.
- 10.(currently amended) A method as claimed in claim 21, wherein said pattern is Y-shaped and said isotropic etch results in micro-channel splitter.
- 11. (currently amended) A method as claimed in claim 21, wherein said pattern of holes is in the form of an array with a narrow portion and a wide portion, and said isotropic etch results in micro-channel that widens out from a narrow portion to a wide portion.
- 12.(currently amended) A method as claimed in claim 21, wherein said layer of etchable material is SiO₂.
- 13.(original) A method as claimed in claim 12, wherein said layer of etchable material is deposited by PECVD.
- 14.(currently amended) A method as claimed in claim 1312, wherein said support layer is made of Si₃N₄.
- 15.(currently amended) A method as claimed in claim 14, wherein a sacrificial layer is deposited under said support layer prior to deposition of said support layer.
- 16.(currently amended) A method as claimed in claim 451, wherein a sacrificial layer is deposited on top of said support layer prior to performing said anisotropic etch.
- 17.(currently amended) A method as claimed in claim 1716, wherein each said sacrificial layer is removed by etching at least in the vicinity of the micro-channel after formation of said micro-channel.
- 18.(original) A method as claimed in claim 1, wherein said layer of etchable material is deposited onto a substrate containing an active device.
- 19.(original) A method as claimed in claim 18, wherein said active device is a CMOS device.
- 20.(original) A method of fabricating a microstructure for micro-fluidics applications, comprising the steps of:

forming a layer of etchable material on a substrate;

forming a first sacrificial layer on said etchable material;

forming a mechanically stable support layer on said first sacrificial layer;

forming a second sacrificial layer on said support layer, providing a mask;

performing an anisotropic etch through said mask to form a pattern of holes extending through said support layer into said etchable material, said holes being separated from each other by a predetermined distance;

performing an isotropic etch through each said hole to form a corresponding cavity in said etchable material under each said hole and extending under said support layer;

removing each of said first and second sacrificial layers to expose said support layer; and forming a further layer of depositable material over said support layer until portions of said depositable layer overhanging each said hole meet and thereby close the cavity formed under each said hole.

- 21.(original) A method as claimed in claim 20, wherein a further sacrificial layer is deposited after forming said holes and prior performing said isotropic etch to form sidewall spacers for said holes.
- 22.(original) A method as claimed in claim 21, wherein said sacrificial layers are TiN.
- 23.(original) A method as claimed in claim 22, wherein said TiN is deposited by CRPVD.
- 24.(original) A method as claimed in claim 20, wherein said holes are arranged in a pattern along the path of a projected micro-channel and said cavities overlap to form said micro-channel.
- 25.(original) A method as claimed in claim 20, wherein said further layer of depositable material is Si0₂.
- 26.(original) A method as claimed in claim 25, wherein said further layer is deposited by PECVD.
- 27.(original) A method of fabricating a microstructure for micro-fluidics applications, comprising the steps of:

forming a layer of etchable material on a substrate;

forming a mechanically stable support layer on said first sacrificial layer over said layer of etchable material;

forming a sacrificial layer over said support layer to protect said support layer during a subsequent isotropic etch:

forming a pattern of holes in said mechanically stable support layer;

performing an said isotropic each through each said hole to form a corresponding cavity
in said eachable material under each said hole and extending under said support layer;

removing said sacrificial layer at least in the vicinity of said holes; and

forming a further layer of depositable material over said support layer until portions of said depositable layer overhanging each said hole meet and thereby close the cavity formed under each said hole.

- 28.(original) A method as claimed in claim 27, wherein said pattern of holes is arranged along a projected path of a micro-channel and said cavities overlap to form said micro-channel.
- 29.(original) A method as claimed in claim 28, wherein said further layer of depositable material is SiO₂ deposited by PECVD.
- 30 (new). A method as claimed in claim 14, wherein said depositable material is SiO₂, and said support layer is Si₃N₄.
- 31.(new). A method as claimed in claim 20, wherein said predetermined distance is selected such that said cavities do not overlap in order to leave pillars therebetween.